

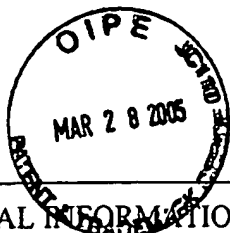
SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT BY APPLICANTS	Application Number	10/789,802
	Filing Date	February 26, 2004
	First Named Inventor	W. Daniel Hillis
	Group Art Unit	2811 2878
	Examiner Name	To be Assigned <i>Salle</i>
Page 1 of 1	Attorney Docket Number	0803-001-022-000000

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	AJ				
	AK				

NON PATENT LITERATURE DOCUMENTS		
Examiner Initials	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page number(s), volume-issue number(s), publisher, city and/or country where published.
<i>JS</i>	AL	LYON, RICHARD F.; FOVEON X3; "'Roots' of Electronic Color Photography & Color Photography with the Foveon X3 Sensor Technology"; Slides from Chief Scientist Richard F. Lyon; bearing no date; pgs. 1-49.
<i>AB</i>	AM	"See what you've been missing: FOVEON X3"; bearing a copyright date of 2002 Foveon, Inc.; pgs. 1-8.
	AN	
	AO	
	AP	
	AQ	
	AR	
	AS	

Examiner Signature	<i>Stephen Ball</i>	Date Considered	6/26/05
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	Group Art Unit	<del>2811</del> 2878
	Examiner Name	<del>To be Assigned</del> S. Allen
	Attorney Docket Number	0803-001-022-000000
Page 1 of 1		

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	AM	
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	AS	

Examiner Signature	<i>Stephen Ball</i>	Date Considered	6/26/05
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OMB 0651-0031

http://isf\_share/Shared Documents/Patents Filed-Active Drafts/Digital Cameras-001/0803-001-022-Intensity Detector Circuitry/PTO-1449 - 3.doc

INFORMATION DISCLOSURE STATEMENT BY APPLICANTS	Application Number	<del>To Be Assigned</del> 10789802
	Filing Date	February 26, 2004
	First Named Inventor	W. Daniel Hillis
	Group Art Unit	2878
	Examiner Name	S. Allen
Page 1 of 1	Attorney Docket Number	0803-001-022-000000

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Examiner Signature	<i>Stephen B. Allen</i>	Date Considered	6/26/05
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